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Test Report

Report Number:

F220520E7

Equipment under Test (EUT):

MGB-L2B-PNA-R-161481

Applicant:

EUCHNER GmbH + Co. KG

Manufacturer:

EUCHNER GmbH + Co. KG



Deutsche
Akkreditierungsstelle
D-PL-17186-01-01
D-PL-17186-01-02
D-PL-17186-01-03

References

- [1] **IEEE Std C95.3™-2021** IEEE Recommended Practice for Measurements and Computations of Electric, Magnetic, and Electromagnetic Fields with Respect to Human Exposure to Such Fields, 0 Hz to 300 GHz
- [2] **IEEE Std C95.1™-2019**, IEEE Standard for Safety Levels with Respect to Human Exposure to Electric, Magnetic, and Electromagnetic Fields, 0 Hz to 300 GHz. (Revision of IEEE Std C95.1-2005/ Incorporates IEEE Std C95.1-2019/Cor 1-2019)

Test Result

The requirements of the tests performed as shown in the overview (clause 4) were fulfilled by the equipment under test. The complete test results are presented in the following.

“Passed” indicates that the equipment under test conforms with the relevant limits of the testing standard without taking any measurement uncertainty into account. However, the measurement uncertainty is calculated and shown in this test report.

Tested and written
by:

Signature

Reviewed and
approved by:

Signature

This test report is only valid in its original form.

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The test results herein refer only to the tested sample. PHOENIX TESTLAB GmbH is not responsible for any generalisations or conclusions drawn from these test results concerning further samples. Any modification of the tested samples is prohibited and leads to the invalidity of this test report. Each page necessarily contains the PHOENIX TESTLAB Logo and the TEST REPORT NUMBER.

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1 Identification

1.1 Applicant

Name:	EUCHNER GmbH + Co. KG
Address:	Kohlhammerstr. 16, 70771 Leinfelden-Echterdingen
Country:	Germany
Name for contact purposes:	Mr. Tobias LEHMANN
Phone:	+49 (0) 711-7597-145
eMail address:	tobias.lehmann@euchner.de
Applicant represented during the test by the following person:	None

1.2 Manufacturer

Name:	EUCHNER GmbH + Co. KG
Address:	Kohlhammerstr. 16, 70771 Leinfelden-Echterdingen
Country:	Germany
Name for contact purposes:	Mr. Tobias LEHMANN
Phone:	+49 (0) 711-7597-145
eMail address:	tobias.lehmann@euchner.de
Manufacturer represented during the test by the following person:	None

1.3 Test Laboratory

The tests were carried out by:

PHOENIX TESTLAB GmbH
Königswinkel 10
32825 Blomberg
Germany

Accredited by Deutsche Akkreditierungsstelle GmbH (DAkkS) in compliance with DIN EN ISO/IEC 17025 under Reg. No. D-PL-17186-01-06 and D-PL-17186-01-05, FCC Test Firm Designation Number DE0004, FCC Test Firm Registration Number 469623, CAB Identifier DE0003 and ISED# 3469A.

1.4 EUT (Equipment under Test)

Test object: *	MGB-L2B-PNA-R-161481
Model name: *	MGB-L2B-PNA-R-161481
Model number: *	161481
Order number: *	161481
FCC ID: *	2AJ58-19
IC certification number: *	22052-19
PMN: *	MGB-L0-PN Series MGB-L1-PN Series MGB-L2-PN Series
HVIN: *	19
FVIN: *	N/A

Type plate EUT



One EUT was used for all tests.

Note: PHOENIX TESTLAB GmbH does not take samples. The samples used for tests are provided exclusively by the applicant.

1.5 Technical Data of Equipment

General			
Power supply EUT: *	DC		
Supply voltage EUT: *	$U_{nom} = 24\text{ V}$	$U_{nom} = 20.4\text{ V}$	$U_{nom} = 27.6\text{ V}$
Temperature range: *	$-25\text{ }^{\circ}\text{C}$ to $+55\text{ }^{\circ}\text{C}$		
Lowest / highest internal frequency: *	125 kHz / 150 MHz		

* Declared by the applicant

RFID part			
Operating frequency: *	125 kHz		
Number of channels: *	1		
Type of modulation: *	AM		
Data rate: *	4 bits / ms, Manchester coded		
Duty cycle: *	50 %		
Antenna type: *	Ring		
Antenna connector: *	None		

* Declared by the applicant

Ports / Connectors				
Identification	Connector		Length during test	Shielding (Yes / No)
	EUT	Ancillary		
X1 DC supply	7/8" 5 Pin Socket male	7/8" 5 Pin Plug female	3 m	No
X2 DC supply	7/8" 5 Pin Socket female	Left open	-	-
X3 PN 2 (SPS)	M12 4 Pin Socket female	Left open	-	-
X4 PN 1 (SPS)	M12 4 Pin Socket female	M12 4 Pin Socket male	5 m	No

Equipment used for testing	
TAG ¹ (Handel-Module)	
Bus module ¹	

¹ Provided by the applicant

² Provided by the laboratory

Ancillary equipment

SPS* ¹	Siemens SIMATIC S7-1200
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*¹ Provided by the applicant

*² Provided by the laboratory

1.6 Dates

Date of receipt of test sample:	22.08.2022
Start of test:	14.09.2022
End of test:	14.09.2022

2 Operational States

Description of function of the EUT:

The EUT is a 125 kHz RFID system used as an authorization system or lockout system.

The following states were defined as the operating conditions:

During all test the EUT was supplied by 24 V DC via AC adapter.

The tests were carried out with an unmodified sample, which operates in normal mode searching for a TAG.

The EUT was set up as follows:



3 Additional Information

The EUT was labeled as required by FCC / IC.

The measurement was carried out without TAG because that was the worst position of the probe.

4 Overview

Whole-body exposure ERLs (100 kHz to 300 GHz)

Because of the difficulty in determining whether an exposure complies with the DRLs, ERLs were derived. The ERLs, which protect against adverse health effects associated with heating, are provided in this subclause for convenience in exposure assessments. For human exposure to electromagnetic energy at radio frequencies from 100 kHz to 300 GHz, the ERLs, in terms of rms electric (E) and magnetic (H) field strengths, the power density (S) and plane-wave-equivalent power densities (SE, SH) are presented as a function of frequency in Table 7 and Table 8. For uncorrelated (in time) fields, such as multiple field exposure situations (e.g., different frequency field sources), compliance is determined by summing the percentages of the applicable ERLs in terms of E^2 , H^2 , or power density that each frequency field represents and ensuring that this sum does not exceed 100 % (IEC/TR 62630 [B659]). If exposure levels are determined via theoretical analysis, consideration of possible reflections of fields shall be included. For frequencies between 100 kHz and 6 GHz, compliance with Table 7 and Table 8 implies compliance with the DRLs for WBA SAR. However, lack of compliance with Table 7 and Table 8 does not necessarily imply lack of compliance with the DRLs, but rather to demonstrate compliance, it shall then be necessary to perform additional evaluations to determine whether the DRLs have been met. If the DRLs given earlier are not exceeded, the ERLs in Table 7 and Table 8 may be exceeded. Consequently, it is sufficient to demonstrate compliance with either the whole-body DRLs in Table 5 (see 4.3.1) or the whole-body ERLs in Table 7 or Table 8. Note that between 6 GHz and 300 GHz, the ERLs in Table 7 and Table 8 are in terms of field strength and power density, and whole-body average SAR does not apply.

Glossary:

- ERLs (**E**xposure **R**eference **L**evel)
- DRLs (**D**osimetric **R**eference **L**evel)
- WBA (**W**hole-**B**ody **A**verage)
- SAR (**S**pecific **A**bsorption **R**ate)

Limits according to [2]

Table 7—ERLs for whole-body exposure of persons in unrestricted environments (100 kHz to 300 GHz) [see Figure 3 for graphical representation]

Frequency range (MHz)	Electric field strength (E) ^{a,b,c} (V/m)	Magnetic field strength (H) ^{a,b,c} (A/m)	Power density (S) ^{a,b,c} (W/m ²)		Averaging time (min)
			S_E	S_H	
0.1 to 1.34	614	$16.3 / f_M$	1000	$100\,000 / f_M^2$	30
1.34 to 30	823.8 / f_M	$16.3 / f_M$	$1800 / f_M^2$	$100\,000 / f_M^2$	30
30 to 100	27.5	$158.3 / f_M^{1.668}$	2	$9\,400\,000 / f_M^{3.336}$	30
100 to 400	27.5	0.0729		2	30
400 to 2000	—	—		$f_M / 200$	30
2000 to 300 000	—	—		10	30

NOTE— S_E and S_H are plane-wave-equivalent power density values, based on electric or magnetic field strength respectively, and are commonly used as a convenient comparison with ERLs at higher frequencies and are sometimes displayed on commonly used instruments.

^a For exposures that are uniform over the dimensions of the body, such as certain far-field plane-wave exposures, the exposure field strengths and power densities are compared with the ERLs in Table 7. For more typical nonuniform exposures, the mean values of the exposure fields, as obtained by spatially averaging the plane-wave-equivalent power densities or the squares of the field strengths, are compared with the ERLs in Table 7. (See notes to Table 7 through Table 11 in 4.3.5.)

^b f_M is the frequency in MHz.

^c The E , H , and S values are those rms values unperturbed by the presence of the body.

Table 8—ERLs for whole-body exposure of persons permitted in restricted environments (100 kHz to 300 GHz) [see Figure 4 for graphical representation]

Frequency range (MHz)	Electric field strength (E) ^{a,b,c} (V/m)	Magnetic field strength (H) ^{a,b,c} (A/m)	Power density (S) ^{a,b,c} (W/m ²)		Averaging time (min)
			S_E	S_H	
0.1 to 1.0	1842	$16.3 / f_M$	9000	$100\,000 / f_M^2$	30
1.0 to 30	1842 / f_M	$16.3 / f_M$	$9000 / f_M^2$	$100\,000 / f_M^2$	30
30 to 100	61.4	$16.3 / f_M$	10	$100\,000 / f_M^2$	30
100 to 400	61.4	0.163		10	30
400 to 2000	—	—		$f_M / 40$	30
2000 to 300 000	—	—		50	30

NOTE— S_E and S_H are plane-wave-equivalent power density values, based on electric or magnetic field strength respectively, and are commonly used as a convenient comparison with ERLs at higher frequencies and are sometimes displayed on commonly used instruments.

^a For exposures that are uniform over the dimensions of the body, such as certain far-field plane-wave exposures, the exposure field strengths and power densities are compared with the ERLs in Table 8. For more typical nonuniform exposures, the mean values of the exposure fields, as obtained by spatially averaging the plane-wave-equivalent power densities or the squares of the field strengths, are compared with the ERLs in Table 8. (See notes to Table 7 through Table 11 in 4.3.5.)

^b f_M is the frequency in MHz.

^c The E , H , and S values are those rms values unperturbed by the presence of the body.

IEEE Std C95.1-2019
 IEEE Standard for Safety Levels with Respect to Human Exposure to Electric, Magnetic, and Electromagnetic Fields, 0 Hz to 300 GHz

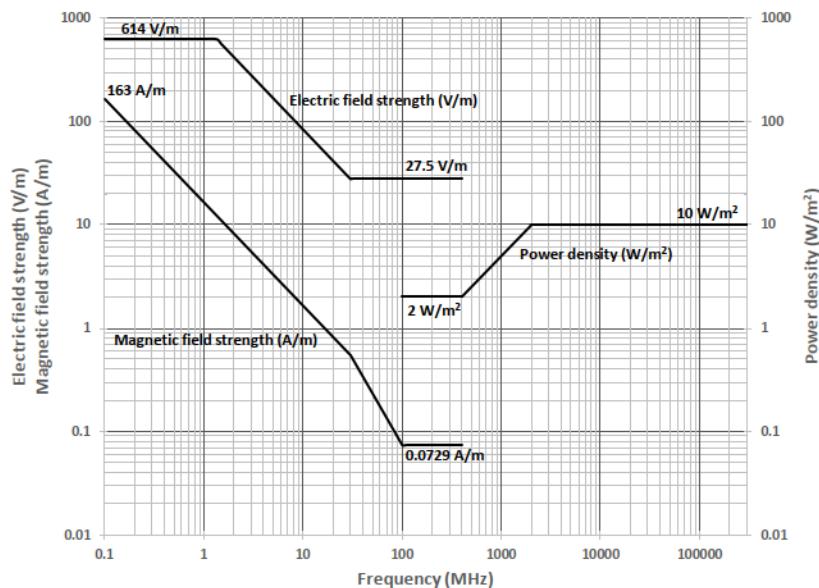


Figure 3—Graphical representations of the ERLs in Table 7 for electric and magnetic fields and plane-wave-equivalent power density—Persons in unrestricted environments

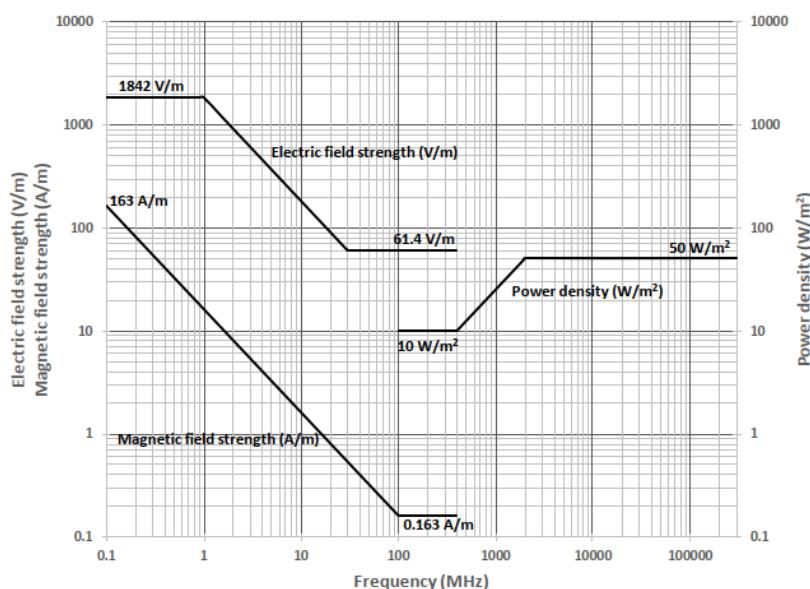


Figure 4—Graphical representations of the ERLs in Table 8 for electric and magnetic fields and plane-wave-equivalent power density—Persons permitted in restricted environments

5 Results

5.1 Measurement of E and H field strength

Ambient temperature:	22 °C
Relative humidity:	54 %

Date:	14.09.2022
Tested by:	M.DINTER

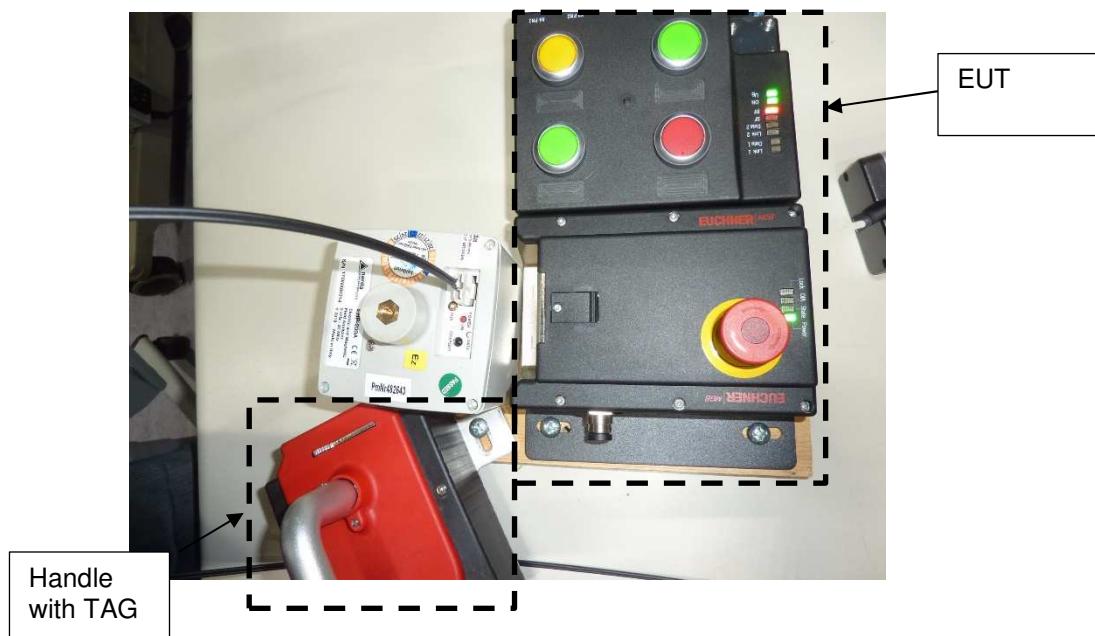
The EUT operates in the frequency range 100 kHz to 300 GHz (operating frequency = 125 kHz).

Because the EUT can be touched by the user's hands during normal operation the field probe was placed directly in front of the EUT (measurement without reading TAG), which means a measuring distance of 0 cm. The position of the maximum field strength and the test setup are shown in the photograph below.

Parameter	Result	Limit	Test result
Electric field strength	9.2 V/m at 0 cm distance (max hold)*2	614 V/m	Passed *
Measurement uncertainty	20.62 %		

* The MGB-L2B-PNA-R-161481 generates an electric field strength, which is below the level for ERLs for whole-body exposure of persons in unrestricted environments [2].

Remark*2: The measurement was carried out in max hold function. A measurement with RMS over 30 minutes will generate less field strength than noted here.



Test equipment (please refer to chapter 7 for details)
1

Ambient temperature:	22 °C
Relative humidity:	54 %

Date:	14.09.2022
Tested by:	M.DINTER

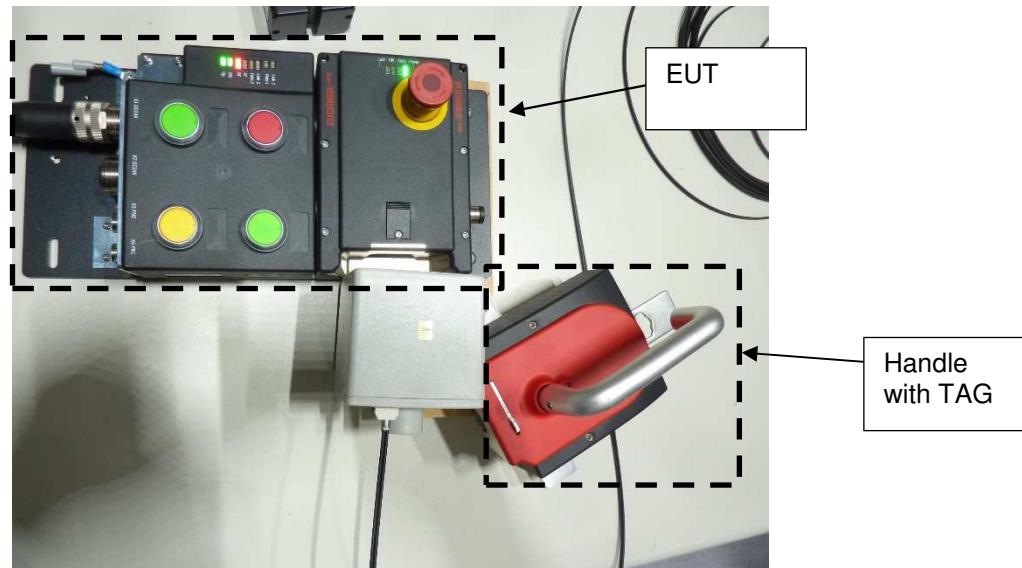
The EUT operates in the frequency range 100 kHz to 300 GHz (operating frequency = 125 kHz).

Because the EUT can be touched by the user's hands during normal operation the field probe was placed directly in front of the EUT (measurement without reading TAG), which means a measuring distance of 0 cm. The position of the maximum field strength and the test setup are shown in the photograph below.

Parameter	Result	Limit	Test result
Magnetic field strength	2.2 A/m at 0 cm distance (RMS over 6 minutes)	130.4 A/m	Passed *
Measurement uncertainty	20.62 %		

* The MGB-L2B-PNA-R-161481 generates a magnetic field strength, which is below the level for ERLs for whole-body exposure of persons in unrestricted environments [2].

Remark*2: The measurement was carried out in max hold function. A measurement with RMS over 30 minutes will generate less field strength than noted here.



Test equipment (please refer to chapter 7 for details)
1

6 Test Equipment used for Tests

No.	Test equipment	Type	Manufacturer	Serial No.	PM. No.	Cal. Date	Cal. Due
1	Isotropical E- and H-field analyser	EHP-200A	Narda	170WX80314	482643	25.03.2021	03.2023

7 Report History

Report Number	Date	Comment
F220520E7	24.11.2023	Initial Test Report
-	-	-
-	-	-